BTH151S-650R

GENERAL DESCRIPTION

Passivated thyristor in a plastic envelope, suitable for surface mounting, intended for use in applications requiring high bidirectional blocking voltage capability and high thermal cycling performance. This thyristor has a high repetitive surge specification which makes it suitable for applications where high inrush currents or stall currents are likely to occur on a repetitive basis.

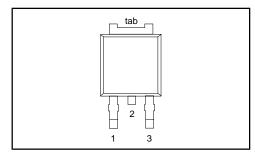
QUICK REFERENCE DATA

SYMBOL	PARAMETER	MAX.	UNIT
V _{DRM} , V _{RRM} I _{T(AV)} I _{T(RMS)} I _{TSM} I _{TRM}	Repetitive peak off-state voltages Average on-state current RMS on-state current Non-repetitive peak on-state current Repetitive peak on-state current	650 7.5 12 110 60	V A A A

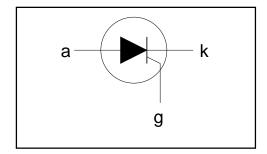
PINNING - SOT428

PIN DESCRIPTION	
1	cathode
2	anode
3	gate
tab	anode

PIN CONFIGURATION



SYMBOL



LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{DRM} , V _{RRM}	Repetitive peak off-state voltages	half sine wave;	-	¹ 650	V
I _{T(AV)}	Average on-state current	T _{mb} ≤ 103 °C	_	7.5	A
I _{T(RMS)}	RMS on-state current Non-repetitive peak on-state current	all conduction angles half sine wave; $T_j = 25$ °C prior to surge	-	12	Ä
	on-state current	t = 10 ms	-	110	A
		t = 8.3 ms	-	121	l A l
I _{TRM}	Repetitive peak on-state current	$t = 10$ ms, $\tau = 3$ s, $T_{mb} \le 45$ °C, no. of surges = 100k	-	60	A
l ² t	I ² t for fusing	t = 10 ms	-	61	A ² s
dl _⊤ /dt	Repetitive rate of rise of on-state current after triggering	$I_{TM} = 20 \text{ A}; I_G = 50 \text{ mA}; \\ dI_G/dt = 50 \text{ mA/}\mu\text{s}$	-	50	A/μs
la	Peak gate current		_	2	Α
$V_{\rm GM}$	Peak gate voltage		_	2 5	Ϊ́Ι
V _{RGM}	Peak reverse gate voltage		-	5	ΙνΊ
P _{GM}	Peak gate power		-	5	l w l
$P_{G(AV)}$	Average gate power	over any 20 ms period	-	0.5	l W l
T _{stg}	Storage temperature		-40	150	°C
T _j	Operating junction temperature		-	125	°C

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¹ Although not recommended, off-state voltages up to 800V may be applied without damage, but the thyristor may switch to the on-state. The rate of rise of current should not exceed 15 $A/\mu s$.

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THERMAL RESISTANCES

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
	Thermal resistance			-	1.8	K/W
R _{th i-a}	junction to mounting base Thermal resistance junction to ambient	pcb (FR4) mounted; footprint as in Fig.14	-	75	-	K/W

STATIC CHARACTERISTICS

 $T_i = 25$ °C unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I _{GT}	Gate trigger current	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}$	-	2	15	mΑ
l IĽ	Latching current	$V_{\rm D} = 12 \text{ V}; I_{\rm GT} = 0.1 \text{ A}$	-	10	40	mΑ
I _H	Holding current	$V_D = 12 \text{ V}; I_{GT} = 0.1 \text{ A}$	-	7	20	mΑ
Ϊ́Τ	On-state voltage	$I_{T} = 23 \text{ A}$	-	1.4	1.75	V
V _{GT}	Gate trigger voltage	$\dot{V}_{D} = 12 \text{ V}; I_{T} = 0.1 \text{ A}$	-	0.6	1.5	V
		$V_D = V_{DRM(max)}$; $I_T = 0.1 \text{ A}$; $T_j = 125 ^{\circ}\text{C}$	0.25	0.4	-	V
I_D, I_R	Off-state leakage current	$V_D = V_{DRM(max)}$; $V_R = V_{RRM(max)}$; $T_j = 125$ °C	-	0.1	0.5	mA

DYNAMIC CHARACTERISTICS

 $T_i = 25$ °C unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
dV _D /dt	Critical rate of rise of off-state voltage	V_{DM} = 67% $V_{DRM(max)}$; T_j = 125 °C; exponential waveform; Gate open circuit R_{GK} = 100 Ω	50 200	130 1000	-	V/μs V/μs
\mathbf{t}_{gt}	Gate controlled turn-on time	$I_{TM} = 40 \text{ A}; V_D = V_{DRM(max)}; I_G = 0.1 \text{ A};$ $dI_G/dt = 5 \text{ A}/\mu\text{s}$	-	2	-	μs
t _q	Circuit commutated turn-off time	$V_D = 67\% \ V_{DRM(max)}; T_j = 125 \ ^{\circ}C;$ $I_{TM} = 20 \ A; \ V_R = 25 \ V; \ dI_{TM}/dt = 30 \ A/\mu s;$ $dV_D/dt = 50 \ V/\mu s; \ R_{GK} = 100 \ \Omega$	-	70	-	μs

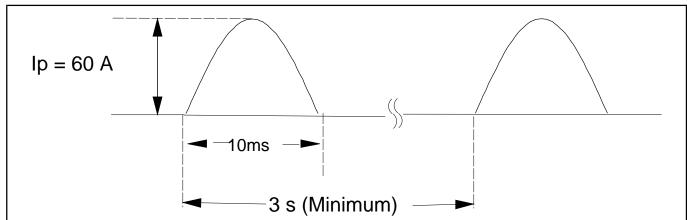


Fig.1. Repetitive surge conditions. I_P =60A (f=50Hz) at Tc=45°C. Maximum number of cycles n=100k. Repetitive cycle T=3 seconds minimum.

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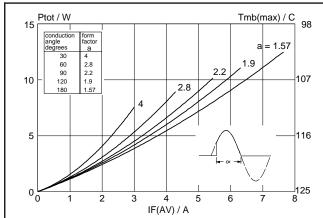


Fig.2. Maximum on-state dissipation, P_{tot} , versus average on-state current, $I_{T(AV)}$, where $a = form\ factor = I_{T(RMS)}/I_{T(AV)}$.

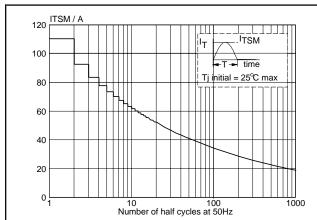


Fig.5. Maximum permissible non-repetitive peak on-state current I_{TSM} , versus number of cycles, for sinusoidal currents, f = 50 Hz.

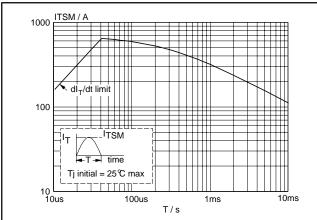


Fig.3. Maximum permissible rms current $I_{T(RMS)}$, versus mounting base temperature T_{mb} .

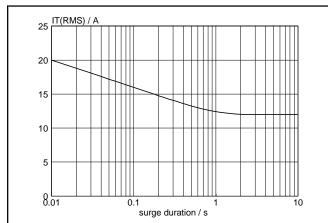


Fig.6. Maximum permissible repetitive rms on-state current $I_{T(RMS)}$, versus surge duration, for sinusoidal currents, f = 50 Hz; $T_{mb} \le 103$ °C.

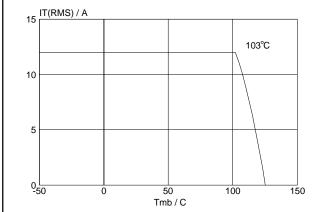
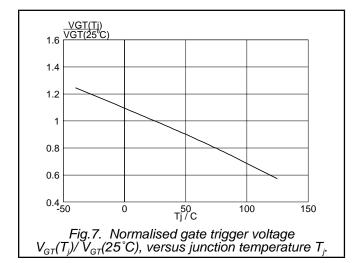
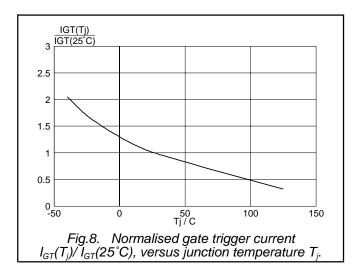
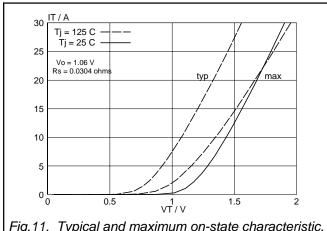


Fig.4. Maximum permissible rms current $I_{T(RMS)}$, versus mounting base temperature T_{mb} .



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IL(Tj) IL(25°C) 2.5 2 1 0.5 0 -50

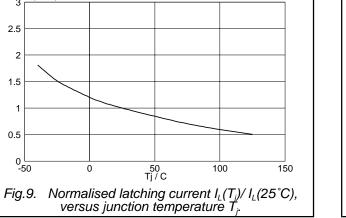
 $_{Tj/C}^{50}$

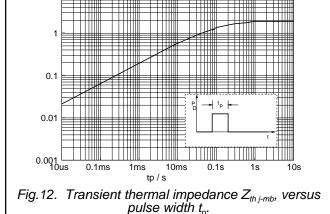
100

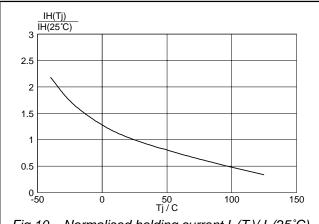
0

Fig.11. Typical and maximum on-state characteristic.

10 Zth j-mb (K/W)







dVD/dt (V/us) 10000 1000 RGK = 100 Ohms 100

Fig. 10. Normalised holding current $I_H(T_i)/I_H(25^{\circ}C)$, versus junction temperature T

Fig.13. Typical, critical rate of rise of off-state voltage, dV_D/dt versus junction temperature $T_{j\cdot}$

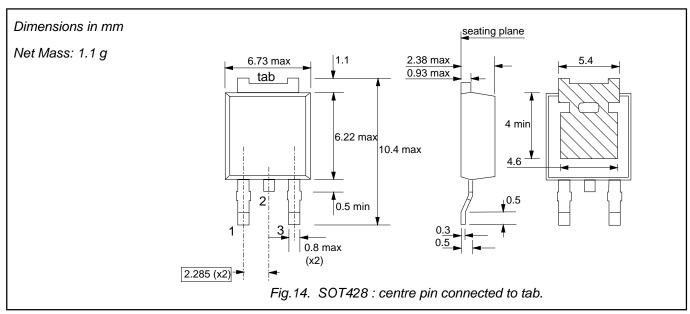
Tj/C

100

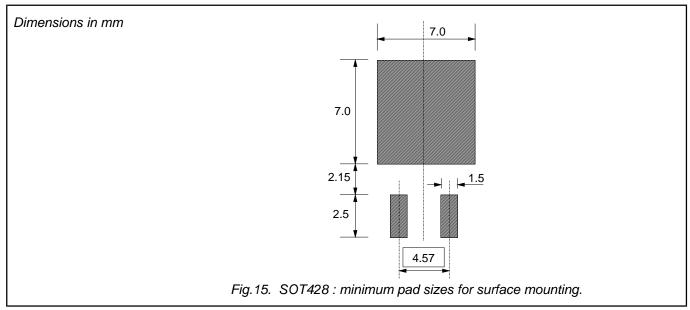
50

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MECHANICAL DATA



MOUNTING INSTRUCTIONS



Notes

1. Plastic meets UL94 V0 at 1/8".

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DEFINITIONS

Data sheet status				
Objective specification	This data sheet contains target or goal specifications for product development.			
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.			
Product specification	This data sheet contains final product specifications.			
1				

Limiting values

Limiting values are given in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of this specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information

Where application information is given, it is advisory and does not form part of the specification.

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